## Search Notes



## Application/Control No. Applicant(s)/Patent Under Reexamination OLLMANN ET AL. Examiner Tan, Alvin H Applicant(s)/Patent Under Reexamination OLLMANN ET AL.

SEARCHED						
Class	Subclass	Date	Examiner			
715	787	6/22/07 (Updated 7/24/08)	/AT/ (/AT/)			

SEARCH NOTES				
Search Notes	Date	Examiner		
715/786 (text search only - see search history printout)	6/22/07 (Updated 7/24/08)	/AT/ (/AT/)		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	6/22/07 (Updated 7/24/08)	/AT/ (/AT/)		
NPL (ACM Digital Library, Google.com)	6/22/07	/AT/		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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